S	Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/732,952	CHEN ET AL.	
Examiner	Art Unit	
Albert W. Paladini	2125	

	SEAR	CHED	
Class	Subclass	Date	Examiner
703	14,15	7/28/2006	AWP
716	4,5	7/28/2006	AWP
716	18	7/28/2006	AWP

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

	EARCH NOT G SEARCH)
		DATE	EXMR
PLUS		7/28/2006	AWP
EAST		7/28/2006	AWP
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